

# International IR Rectifier

PD - 95364

## IRF510PbF

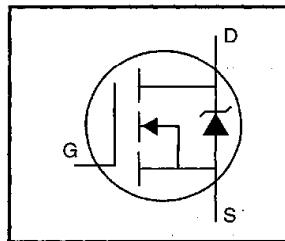
### HEXFET® Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- 175°C Operating Temperature
- Fast Switching
- Ease of Parallelizing
- Simple Drive Requirements
- Lead-Free

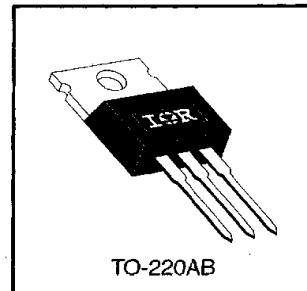
#### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



$V_{DSS} = 100V$
$R_{DS(on)} = 0.54\Omega$
$I_D = 5.6A$



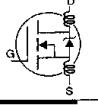
#### Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	5.6	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10 V$	4.0	
$I_{DM}$	Pulsed Drain Current ①	20	
$P_D @ T_C = 25^\circ C$	Power Dissipation	43	W
	Linear Derating Factor	0.29	W/ $^\circ C$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	100	mJ
$I_{AR}$	Avalanche Current ①	5.6	A
$E_{AR}$	Repetitive Avalanche Energy ①	4.3	mJ
$dv/dt$	Peak Diode Recovery $dv/dt$ ③	5.5	V/ns
$T_J$	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ C$
$T_{STG}$	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N·m)	

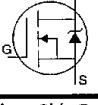
#### Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
$R_{JC}$	Junction-to-Case	—	—	3.5	$^\circ C/W$
$R_{CS}$	Case-to-Sink, Flat, Greased Surface	—	0.50	—	
$R_{JA}$	Junction-to-Ambient	—	—	62	

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	100	—	—	V	$V_{\text{GS}}=0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.12	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	0.54	$\Omega$	$V_{\text{GS}}=10\text{V}, I_D = 3.4\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}}=V_{\text{GS}}, I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	1.3	—	—	S	$V_{\text{DS}}=50\text{V}, I_D = 3.4\text{A}$ ④
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	25	$\mu\text{A}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}$
		—	—	250		$V_{\text{DS}}=80\text{V}, V_{\text{GS}}=0\text{V}, T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{\text{GS}}=20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{\text{GS}}=-20\text{V}$
$Q_g$	Total Gate Charge	—	—	8.3	nC	$I_D = 5.6\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	—	2.3		$V_{\text{DS}}=80\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	—	3.8		$V_{\text{GS}}=10\text{V}$ See Fig. 6 and 13 ④
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	6.9	—		$V_{\text{DD}}=50\text{V}$
$t_r$	Rise Time	—	16	—	ns	$I_D = 5.6\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	15	—		$R_G=24\Omega$
$t_f$	Fall Time	—	9.4	—		$R_D=8.4\Omega$ See Figure 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6 mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{\text{iss}}$	Input Capacitance	—	180	—	pF	$V_{\text{GS}}=0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	81	—		$V_{\text{DS}}=25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	15	—		$f=1.0\text{MHz}$ See Figure 5

**Source-Drain Ratings and Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	5.6	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	20		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	2.5	V	$T_J = 25^\circ\text{C}, I_S = 5.6\text{A}, V_{\text{GS}} = 0\text{V}$ ④
$t_{\text{rr}}$	Reverse Recovery Time	—	100	200	ns	$T_J = 25^\circ\text{C}, I_F = 5.6\text{A}$ $dI/dt = 100\text{A}/\mu\text{s}$ ④
$Q_{\text{rr}}$	Reverse Recovery Charge	—	0.44	0.88	$\mu\text{C}$	
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

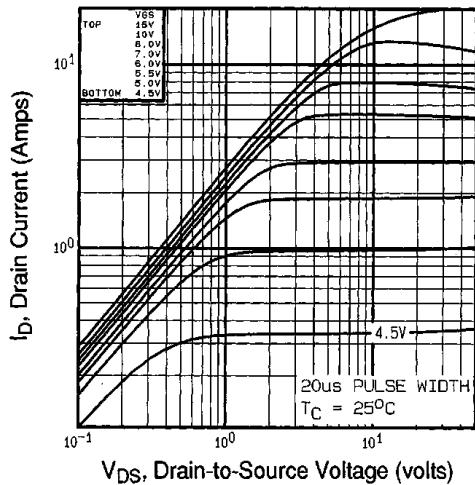
**Notes:**

① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)

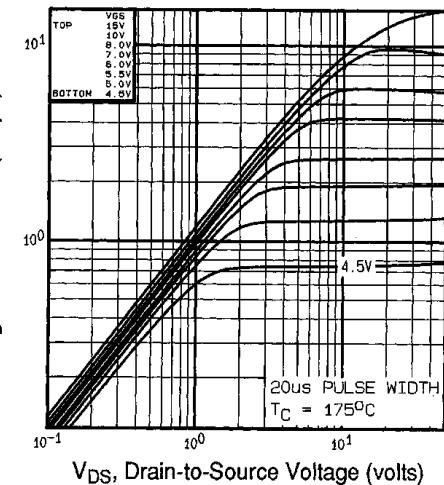
③  $I_{\text{SD}} \leq 5.6\text{A}$ ,  $dI/dt \leq 75\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 175^\circ\text{C}$

②  $V_{\text{DD}}=25\text{V}$ , starting  $T_J=25^\circ\text{C}$ ,  $L=4.8\text{mH}$   
 $R_G=25\Omega$ ,  $I_{AS}=5.6\text{A}$  (See Figure 12)

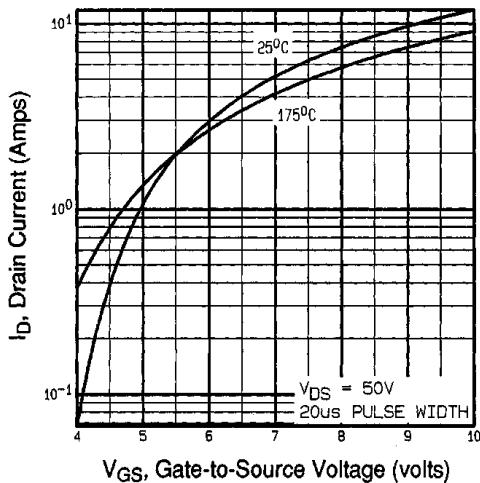
④ Pulse width  $\leq 300\ \mu\text{s}$ ; duty cycle  $\leq 2\%$ .



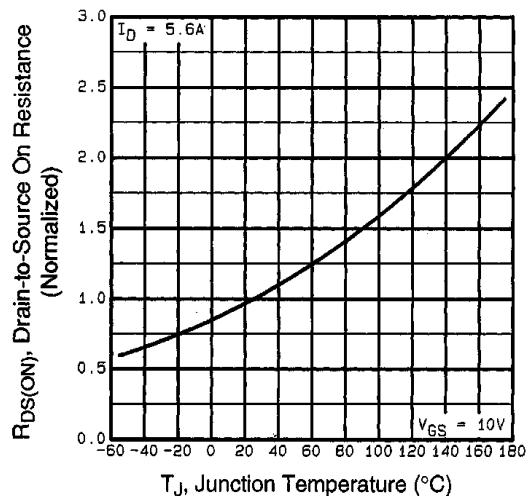
**Fig 1.** Typical Output Characteristics,  
 $T_C = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C = 175^\circ\text{C}$



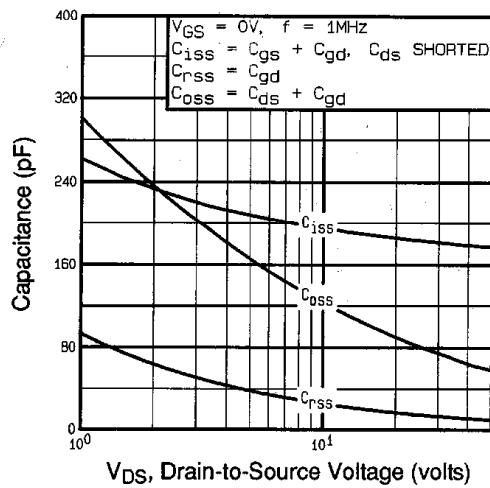
**Fig 3.** Typical Transfer Characteristics



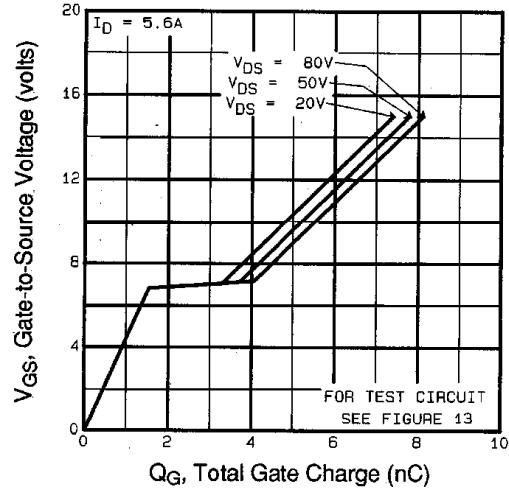
**Fig 4.** Normalized On-Resistance  
 Vs. Temperature

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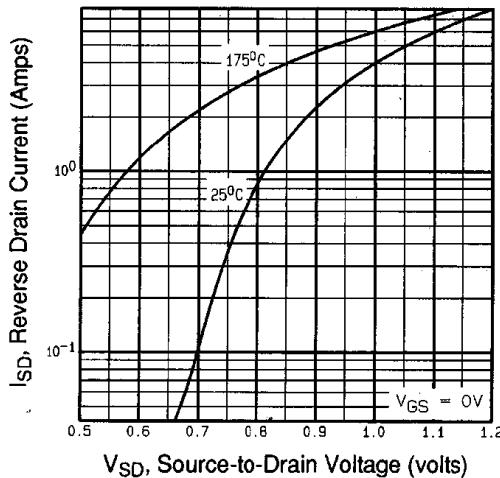
International  
**IR** Rectifier



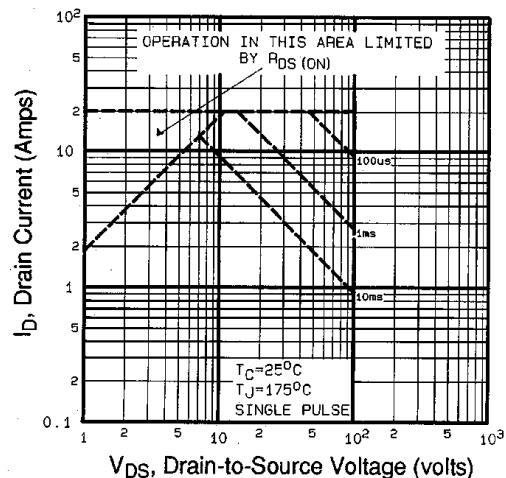
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



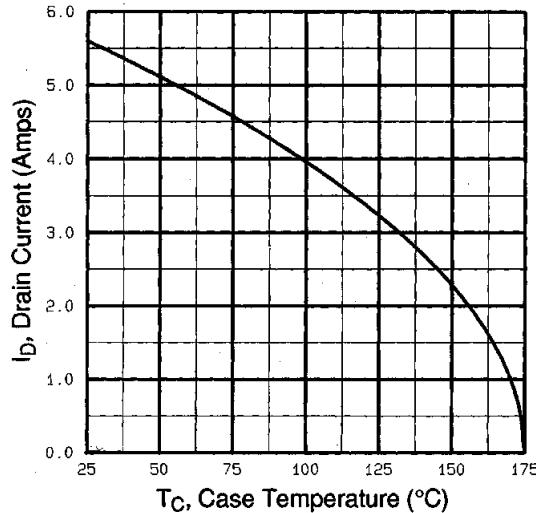
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode  
Forward Voltage

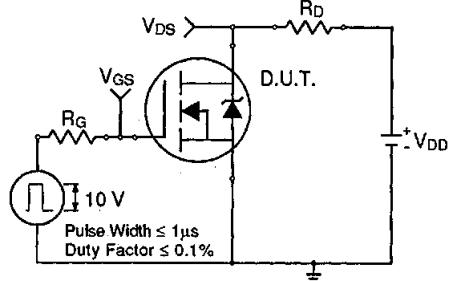


**Fig 8.** Maximum Safe Operating Area

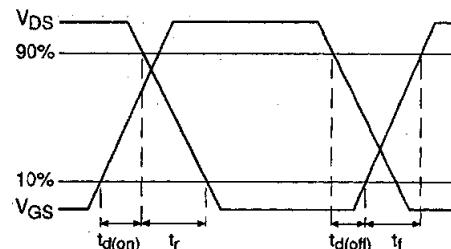


**Fig 9.** Maximum Drain Current Vs.  
Case Temperature

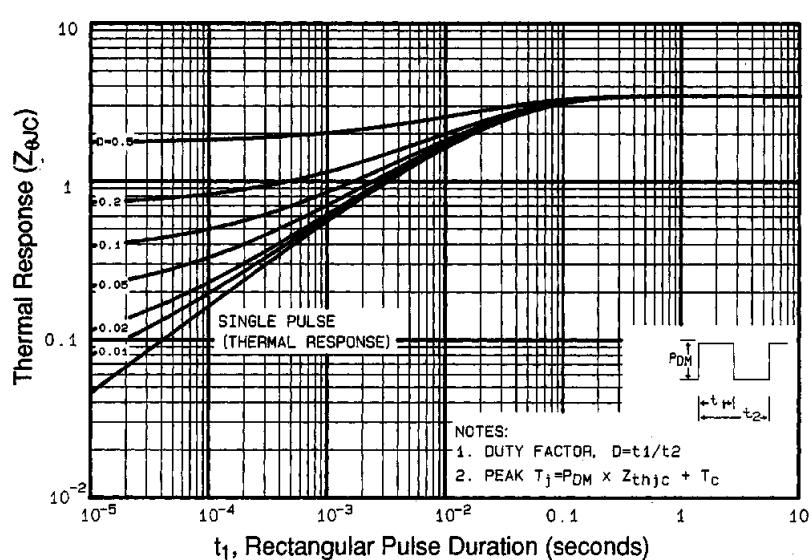
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**Fig 10a.** Switching Time Test Circuit



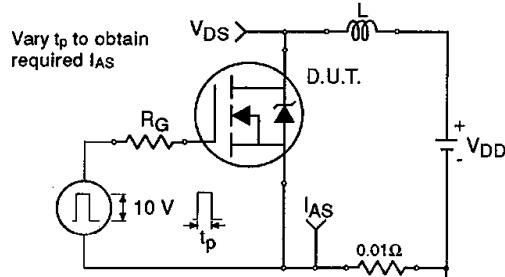
**Fig 10b.** Switching Time Waveforms



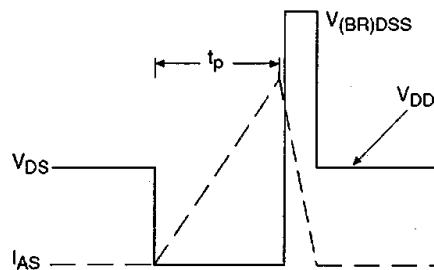
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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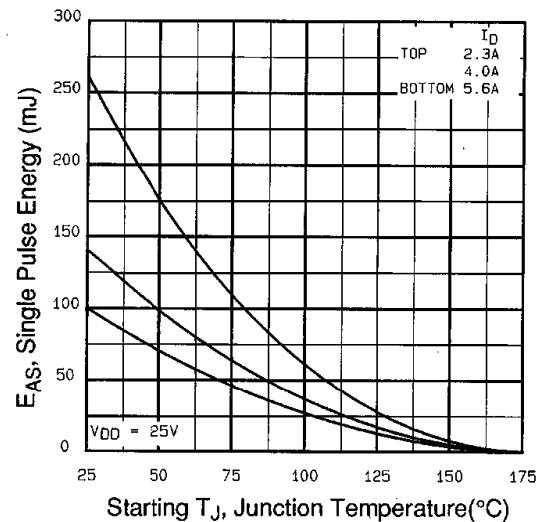
International  
Rectifier



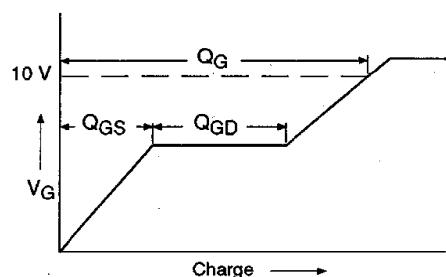
**Fig 12a.** Unclamped Inductive Test Circuit



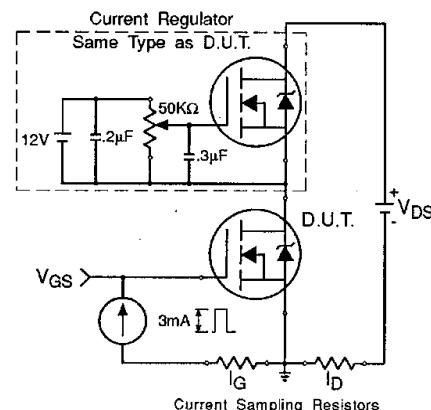
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform

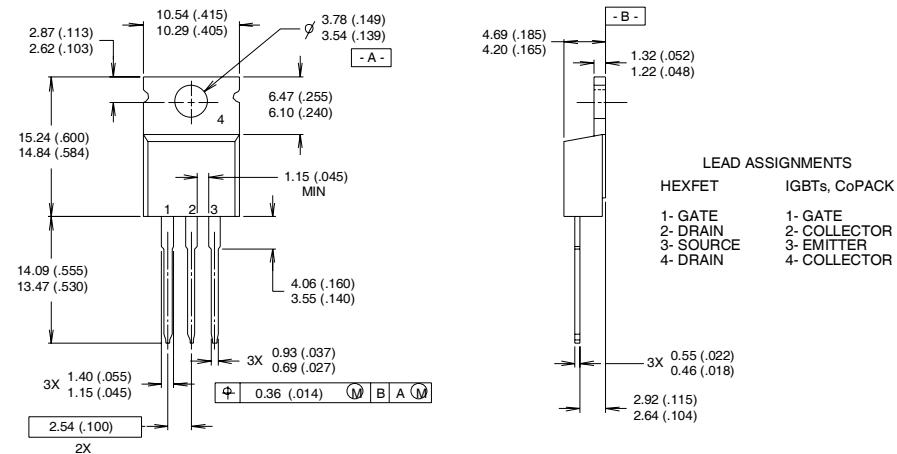


**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery dv/dt Test Circuit – See page 1505

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



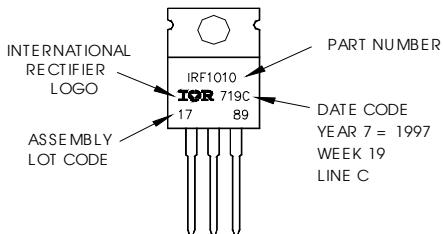
NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH

- 3 OUTLINE CONFORMS TO JEDEC OUTLINE TO-220AB.
- 4 HEATSINK & LEAD MEASUREMENTS DO NOT INCLUDE BURRS.

## TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"  
**Note:** "P" in assembly line  
 position indicates "Lead-Free"



Data and specifications subject to change without notice.

**International**  
**IR** Rectifier

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